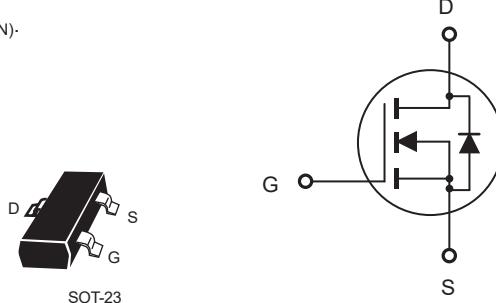


## N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

- 30V, 4.8A,  $R_{DS(ON)} = 34m\Omega$  @ $V_{GS} = 10V$ .  
 $R_{DS(ON)} = 40m\Omega$  @ $V_{GS} = 4.5V$ .  
 $R_{DS(ON)} = 45m\Omega$  @ $V_{GS} = 2.5V$ .  
 $R_{DS(ON)} = 60m\Omega$  @ $V_{GS} = 1.8V$ .
- High dense cell design for extremely low  $R_{DS(ON)}$ .
- Rugged and reliable.
- RoHS compliant.
- SOT-23 package.



### ABSOLUTE MAXIMUM RATINGS

 $T_A = 25^\circ C$  unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Drain Current-Continuous	$I_D$	4.8	A
Drain Current-Pulsed <sup>a</sup>	$I_{DM}$	20	A
Maximum Power Dissipation	$P_D$	1.25	W
Operating and Store Temperature Range	$T_J, T_{stg}$	-55 to 150	$^\circ C$

### Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Ambient <sup>b</sup>	$R_{\theta JA}$	100	$^\circ C/W$



CES2310L

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

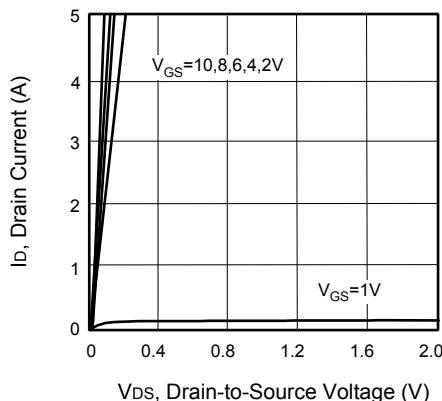
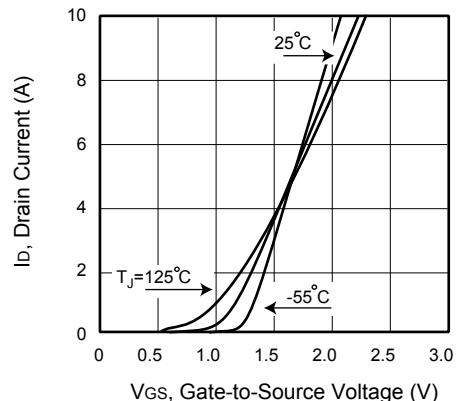
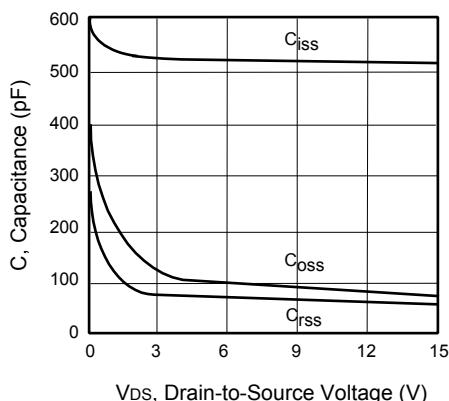
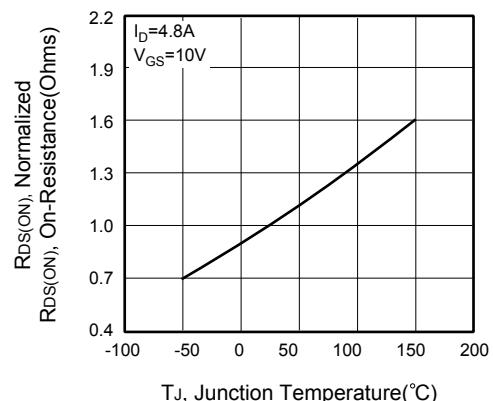
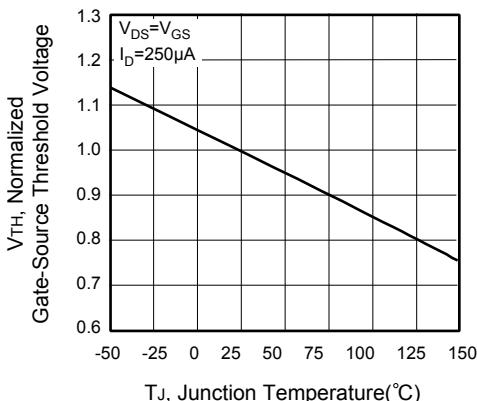
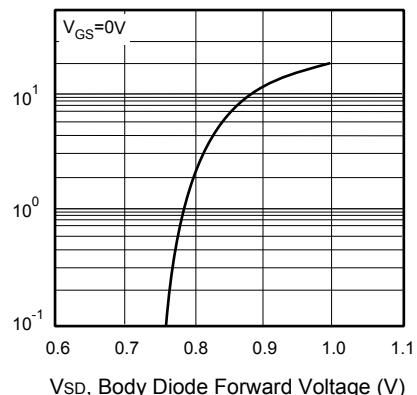
Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	30			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 30\text{V}, V_{\text{GS}} = 0\text{V}$			1	$\mu\text{A}$
Gate Body Leakage Current, Forward	$I_{\text{GSSF}}$	$V_{\text{GS}} = 12\text{V}, V_{\text{DS}} = 0\text{V}$			100	nA
Gate Body Leakage Current, Reverse	$I_{\text{GSSR}}$	$V_{\text{GS}} = -12\text{V}, V_{\text{DS}} = 0\text{V}$			-100	nA
<b>On Characteristics</b> <sup>c</sup>						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}} = V_{\text{DS}}, I_D = 250\mu\text{A}$	0.4		1	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 4.8\text{A}$		24	34	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5\text{V}, I_D = 4\text{A}$		26	40	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5\text{V}, I_D = 2\text{A}$		30	45	$\text{m}\Omega$
		$V_{\text{GS}} = 1.8\text{V}, I_D = 1\text{A}$		34	60	$\text{m}\Omega$
<b>Dynamic Characteristics</b> <sup>d</sup>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}} = 15\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$		520		pF
Output Capacitance	$C_{\text{oss}}$			85		pF
Reverse Transfer Capacitance	$C_{\text{rss}}$			60		pF
<b>Switching Characteristics</b> <sup>d</sup>						
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 15\text{V}, I_D = 4.8\text{A}, V_{\text{GS}} = 4.5\text{V}, R_{\text{GEN}} = 10\Omega$		9		ns
Turn-On Rise Time	$t_r$			6		ns
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$			44		ns
Turn-Off Fall Time	$t_f$			10		ns
Total Gate Charge	$Q_g$	$V_{\text{DS}} = 15\text{V}, I_D = 4.8\text{A}, V_{\text{GS}} = 4.5\text{V}$		10		nC
Gate-Source Charge	$Q_{\text{gs}}$			1		nC
Gate-Drain Charge	$Q_{\text{gd}}$			3		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Drain-Source Diode Forward Current <sup>b</sup>	$I_S$				1.2	A
Drain-Source Diode Forward Voltage <sup>c</sup>	$V_{\text{SD}}$	$V_{\text{GS}} = 0\text{V}, I_S = 1\text{A}$			1	V

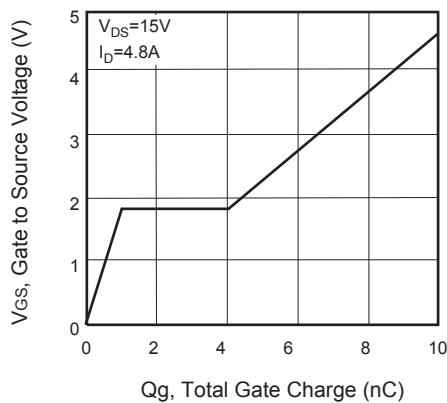
## Notes :

a.Repetitive Rating : Pulse width limited by maximum junction temperature.

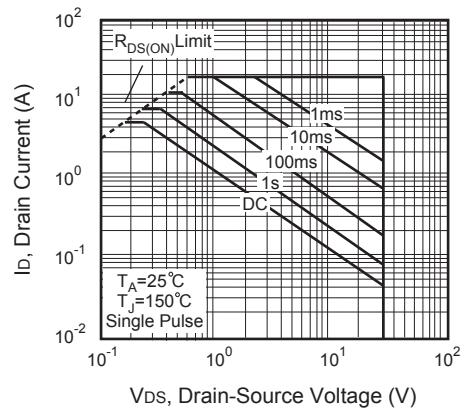
b.Surface Mounted on FR4 Board,  $t < 5 \text{ sec}$ .c.Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ . Duty Cycle  $\leq 2\%$ .

d.Guaranteed by design, not subject to production testing.

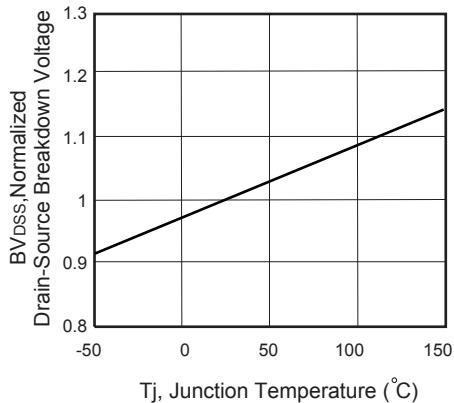
**Figure 1. Output Characteristics****Figure 2. Transfer Characteristics****Figure 3. Capacitance****Figure 4. On-Resistance Variation with Temperature****Figure 5. Gate Threshold Variation with Temperature****Figure 6. Body Diode Forward Voltage Variation with Source Current**



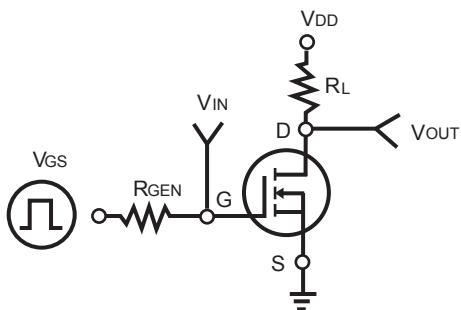
**Figure 7. Gate Charge**



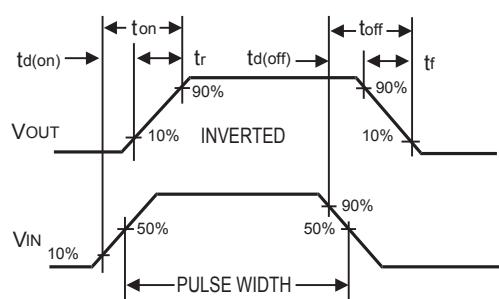
**Figure 8. Maximum Safe Operating Area**



**Figure 9. Breakdown Voltage Variation VS Temperature**



**Figure 10. Switching Test Circuit**



**Figure 11. Switching Waveforms**

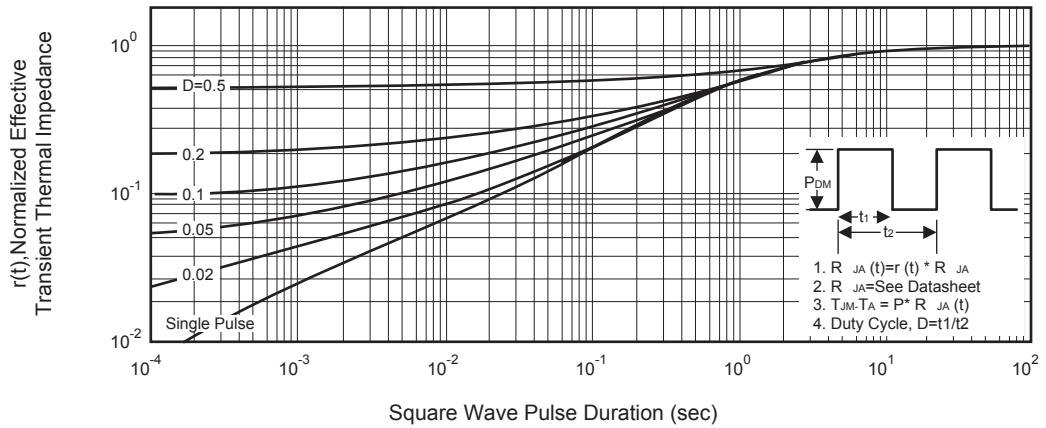


Figure 12. Normalized Thermal Transient Impedance Curve